

# FDS8690

# N-Channel PowerTrench® MOSFET

**30V**, **14A**, **7.6m** $\Omega$ 

## **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $r_{DS(on)}$  and fast switching speed.

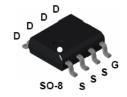
# **Applications**

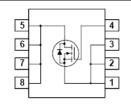
- Notebook CPU power supply
- Synchronous rectifier

#### **Features**

- Max  $r_{DS(on)} = 7.6 m\Omega$ ,  $V_{GS} = 10 V$ ,  $I_D = 14 A$
- Max  $r_{DS(on)} = 11.4m\Omega$ ,  $V_{GS} = 4.5V$ ,  $I_D = 11.5A$
- $\blacksquare$  High performance trench technology for extremely low  $r_{\text{DS(on)}}$  and fast switching
- Very low gate charge
- High power and current handling capability
- 100% R<sub>G</sub> tested
- RoHS Compliant







# Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise Noted

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain to Source Voltage	30	V
$V_{GS}$	Gate to Source Voltage	±20	V
	Drain Current -Continuous (Note	e 1a) 14	Α
ID	-Pulsed	100	A
E <sub>AS</sub>	Single Pulse Avalanche Energy (Not	te 3) 210	mJ
$P_{D}$	Power Dissipation for Single Operation (Note	e 1a) 2.5	
	(Note	e 1b) 1.2	W
	(Note	e 1c) 1.0	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-55 to +150	°C

#### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	°C/W
$R_{\theta,JC}$	Thermal Resistance, Junction to Case	(Note 1)	25	°C/W

# **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Reel Size	Tape Width	Quantity
FDS8690	FDS8690	13"	12mm	2500 units

Max Units

# **Electrical Characteristics** $T_J = 25^{\circ}\text{C}$ unless otherwise noted

**Parameter** 

Off Characteristics							
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V	
$\frac{\Delta B_{VDSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu A$ , referenced to $25^{\circ}C$		34.3		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24V, \ V_{GS} = 0V$			1	μΑ	
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA	

**Test Conditions** 

Min

#### On Characteristics (Note 2)

Symbol

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1	1.6	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> =250μA, referenced to 25°C		- 4.5		mV/°C
r <sub>DS(ON)</sub>	Drain to Source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 14A		6.3	7.6	
		$V_{GS} = 4.5V, I_D = 11.5A$		8.6	11.4	mΩ
	Drain to course of Hesistance	$V_{GS} = 10V, I_D = 14A,$ $T_J = 125^{\circ}C$		9.0	10.9	11152

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 45V V 0V	1260	1680	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 15V, V_{GS} = 0V,$ $f = 1MHz$	535	715	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	- 1111112	80	120	pF
$R_{G}$	Gate Resistance	f = 1MHz	1.1		Ω

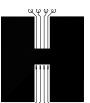
### **Switching Characteristics (Note 2)**

t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> = 15V, I <sub>D</sub> = 1A.	8.0	16	ns
t <sub>r</sub>	Rise Time	$V_{DS} = 15V, I_{D} = 1A,$ $V_{GS} = 10V, R_{GS} = 6\Omega$	1.8	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		26	42	ns
t <sub>f</sub>	Fall Time		19	35	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = 15V, V_{GS} = 10V$ $I_{D} = 14A$	18.8	27	nC
$Q_g$	Total Gate Charge	$V_{DS} = 15V, V_{GS} = 5V$	10	14	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	I <sub>D</sub> = 14A	3.5		nC
Q <sub>gd</sub>	Gate to Drain Charge		2.9		nC

#### **Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 2.1A$	0.7	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 14A$ , di/dt = 100A/ $\mu$ s		45	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$I_F = 14A$ , di/dt = 100A/ $\mu$ s		33	nC

1. R<sub>RJA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 50°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b)105°C/W when mounted on a .04 in<sup>2</sup> pad of 2 oz copper

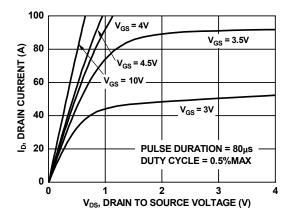




2. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

3. Starting  $T_J = 25^{\circ}C$ , L = 3mH,  $I_{AS} = 11.8A$ ,  $V_{DD} = 24V$ ,  $V_{GS} = 10V$ .

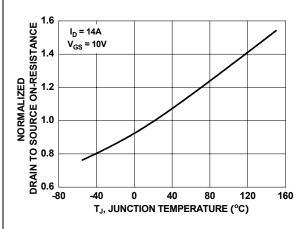




NORMALIZED DRAIN TO SOURCE ON-RESISTANCE 3.2 PULSE DURATION = 80us DUTY CYCLE = 0.5%MAX 2.8 V<sub>GS</sub> = 3.0V 2.4 2.0 V<sub>GS</sub> = 4V 1.6 V<sub>GS</sub> = 4.5V 1.2 V<sub>GS</sub> = 10V 8.0 0 20 80 100 I<sub>D</sub>, DRAIN CURRENT(A)

Figure 1. On Region Characteristics

Figure 2. Normal On-Resistance vs Drain Current and Gate Voltage



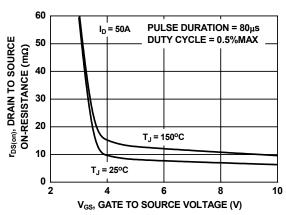
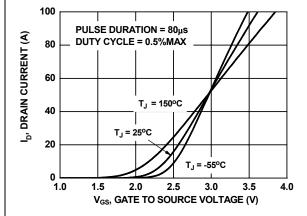


Figure 3. Normalized On Resistance vs Junction Temperature

Figure 4. On-Resistance vs Gate to Source Voltage



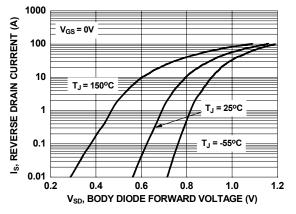
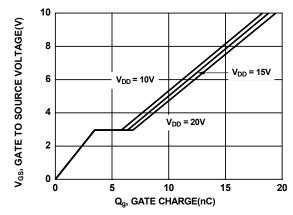


Figure 5. Transfer Characteristics

Figure 6. Source to Drain Diode Forward Voltage vs Source Current





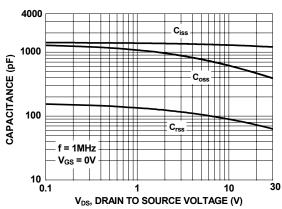
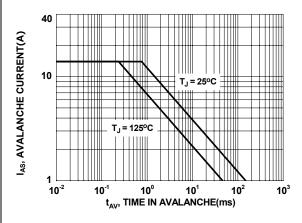


Figure 7. Gate Charge Characteristics





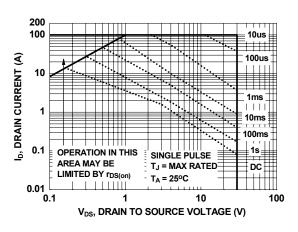
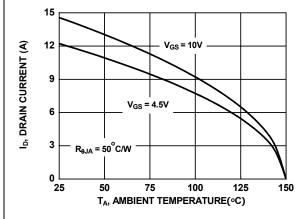


Figure 9. Unclamped Inductive Switching Capability

Figure 10. Forward Bias Safe Operating Area



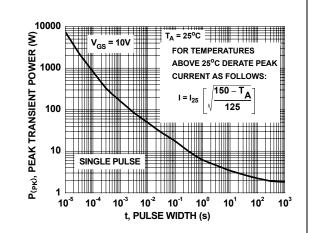


Figure 11. Maximum Continuous Drain Current vs
Ambient Temperature

Figure 12. Single Pulse Maximum Power Dissipation

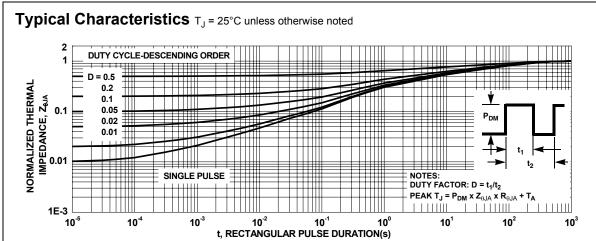


Figure 13. Transient Thermal Response Curve

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